

#### Switched-Capacitor Charge-Pump Voltage Converter IC in bare die form

Rev 1.0 20/07/20

### Description

The SiS7660 converts a +1.5V to +10V supply into a corresponding -1.5V to -10V output. Operation is simple requiring x2 capacitors for charge-pump & charge-reservoir function. The SiS7660 can also function as a voltage doubler, generating output voltages up to +18.6V from a +10V input.

Oscillator, series regulator & logic control circuitry are integrated along with x4 MOS switches. The oscillator, when unloaded, oscillates at a nominal 10kHz with a 5V input supply. Oscillator frequency can be lowered by adding an external capacitor to the "OSC" terminal, or overdriven via an external clock. Tying the "LV" pin to GND bypasses the regulator to improve low voltage operation. At medium to high voltages (+3.5V to +10V) the LV pin is left floating to prevent device latch-up.

## Ordering Information

The following part suffixes apply:

- No suffix MIL-STD-883 /2010B Visual Inspection
- "H" MIL-STD-883 /2010B Visual Inspection+ MIL-PRF-38534 Class H LAT
- "K" MIL-STD-883 /2010A Visual Inspection (Space)
   + MIL-PRF-38534 Class K LAT

LAT = Lot Acceptance Test.

For further information on LAT process flows see below.

www.siliconsupplies.com\quality\bare-die-lot-qualification

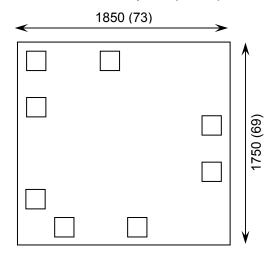
## Supply Formats:

- Default Die in Waffle Pack (100 per tray capacity)
- Sawn Wafer on Tape On request
- Unsawn Wafer On request
- Die Thickness <> 280µm(11 Mils) On request
- In Metal or Ceramic package On request

#### Features:

- Conversion of +5V Logic Supply to -5V
- Simple voltage multiplication (V<sub>OUT</sub> = (-) nV<sub>IN</sub>)
- Latch-up free via internal logic bias sense
- Typical open-circuit voltage conversion efficiency 99.9%
- Typical power efficiency 98%
- Wide Operating Voltage Range 1.5V to 10.0V
- Requires only x2 non-critical capacitors
- Direct replacement for industry standard ICL7660
- Full military temperature range.

## Die Dimensions in µm (mils)



## **Mechanical Specification**

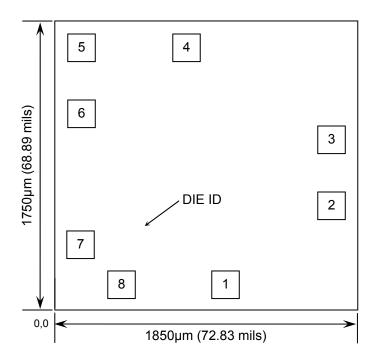
Die Size (Unsawn)	1850 x 1750 73 x 69	μm mils	
Minimum Bond Pad Size	100 x 100 3.94 x 3.94	μm mils	
Die Thickness	280 (±20) 11 (±0.8)	μm mils	
Top Metal Composition	Al 1%Si 1.4μm		
Back Metal Composition	N/A – Bare Si		





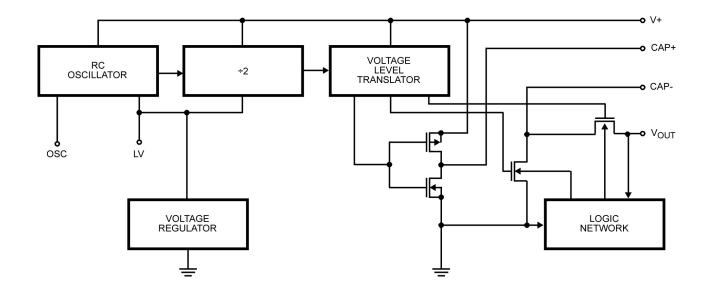
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## Pad Layout and Functions



PAD	FUNCTION	COORDINATES (µm)		
		XY	Y	
1	NC	1019	134	
2	CAP +	1649	507.5	
3	GND	1649	1038	
4	CAP -	832	1549	
5	V <sub>OUT</sub>	101	1549	
6	LV	101	338	
7	OSC	101	1188	
8	V+	253	134	
CONNECT CHIP BACK TO V+ OR FLOAT				

## **Block Diagram**







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## Absolute Maximum Ratings<sup>1</sup> T<sub>A</sub> = 25°C unless otherwise stated

PARAMETER	SYMBOL		VALUE	UNIT	
Supply Voltage (V+ to GND or GND to V <sub>OUT</sub> )	Vs		V <sub>S</sub> +10.5		
LV and OSC Input Voltage <sup>2</sup>		V+ <5.5V	-0.3V to (V+ +0.3V)	V	
EV and Ood input voltage	V <sub>IN</sub>	V+ >5.5V	(V+ -5.5V) to (V+ +0.3V)	v	
Current into LV <sup>2</sup>	I <sub>IN</sub>	V+ >3.5V	20	μΑ	
Output Short-Circuit Duration (V <sub>S</sub> ≤ 5.5V)	-		Continuous		
Operating Junction Temperature Range	TJ		-55 to 125	°C	
Storage Temperature	T <sub>STG</sub>		-65 to 150	°C	

<sup>1.</sup> Operation above the absolute maximum rating may cause device failure. Operation at the absolute maximum ratings, for extended periods, may reduce device reliability. 2. Connecting any input terminal to voltages greater than V+ or less than GND may cause destructive latchup. It is recommended that no inputs from sources operating from external supplies be applied prior to "power up".

### Electrical Characteristics, T<sub>A</sub> = 25°C, V+ = 5V, C<sub>OSC</sub> = 0, unless otherwise stated

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Supply Current	I <sub>+</sub>	R <sub>L</sub> = ∞	-	170	500	μA
Supply Voltage Range	V <sub>1</sub> .	-55°C ≤ T <sub>A</sub> ≤ +125°C, R <sub>L</sub> = 10kΩ, LV to GND	1.5	-	3.5	V
		-55°C ≤ T <sub>A</sub> ≤ +125°C, R <sub>L</sub> = 10kΩ, LV open	3.0	-	10	V
Output Source Resistance	R <sub>OUT</sub>	I <sub>OUT</sub> = 20mA	-	55	100	Ω
		$I_{OUT} = 20\text{mA},$ $-0^{\circ}\text{C} \le T_{A} \le +70^{\circ}\text{C}$	-	-	120	
		$I_{OUT} = 20\text{mA},$ -55°C \le T <sub>A</sub> \le +125°C	-	-	150	
		V+ = 2V, $I_{OUT}$ = 3mA, LV to GND, 0°C $\leq$ T <sub>A</sub> $\leq$ +70°C	-	-	300	
		V+ = 2V, $I_{OUT}$ = 3mA, LV to GND, -55°C ≤ $T_A$ ≤ +125°C	-	-	400	
Oscillator Frequency	f <sub>OSC</sub>	-	8	-	18	kHz
Power Efficiency	P <sub>EF</sub>	$R_L = 5k\Omega$	95	98	-	%
Voltage Conversion Efficiency	V <sub>OUT EF</sub>	R <sub>L</sub> = ∞	97	99.9	-	%
Oscillator Impedance	Z <sub>osc</sub>	V+ = 2V	-	1	-	МΩ
		V+ = 5V	-	100	-	kΩ





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## **Application Notes**

The SiS7660 capacitive charge-pump circuit either inverts, splits or doubles the input voltage (see Typical Applications).

- For highest performance, low effective series resistance (ESR) capacitors should be used
- If using inverting mode with a supply voltage less than +3.5V, LV may be connected to GND. This bypasses the internal regulator circuitry for best performance in low voltage applications. When using the inverter mode with supply voltage above +3.5V, LV must be left open.
- Do not short circuit the output to V+ for supply voltages >5.5V for extended periods, transient conditions including start-up are OK.
- If the voltage supply driving the SiS7660 has a large source impedance  $(25\Omega 30\Omega)$ , a 2.2 $\mu$ F capacitor from pin 8 to ground may be required to limit rate of rise of input voltage to less than  $2V/\mu s$ .
- User should insure that the output (pin 5) does not go more positive than GND (pin 3). Device latch up will occur
  under these conditions. A 1N914 or similar placed in parallel with C2 will prevent the device from latching up
  under these conditions. (Anode pin 5, Cathode pin 3).

## Typical Applications & Adjustment Circuitry

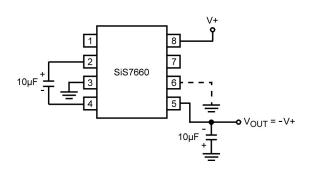


Figure 1 – Negative Voltage Converter

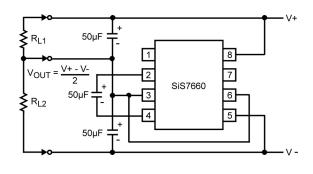


Figure 2 – Splitting supply Voltage in half

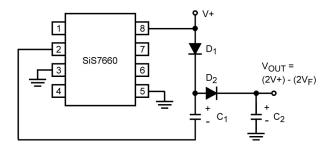
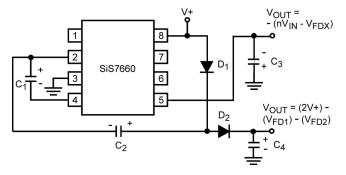


Figure 3 – Positive Voltage Doubler



**Figure 4** – Combined Negative Voltage Converter and Positive Doubler





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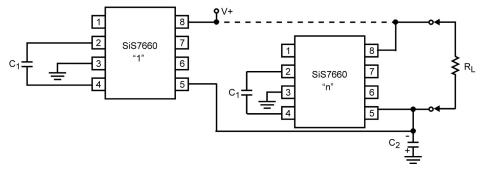


Figure 5 - Paralleling Devices

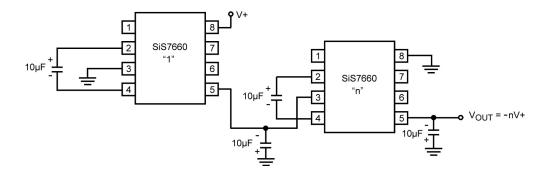


Figure 6 – Cascading devices for increased output voltage

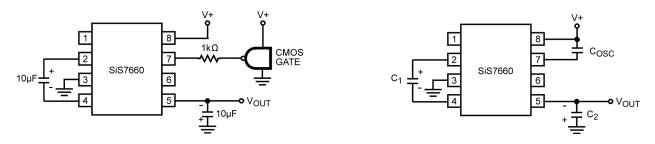


Figure 7 - External Clocking

Figure 8 – Lowering Oscillator frequency

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